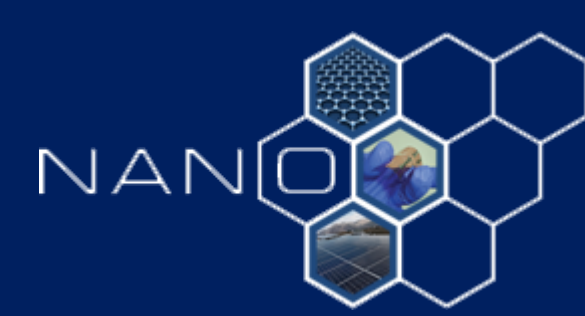


# Reduced Graphene Oxide Ink/Conductive Polymeric Composites for Enhanced Field Emission Devices



Minas M. Stylianakis,<sup>1\*</sup> George Viskadourous,<sup>1,2</sup> Christos Polyzoidis,<sup>1</sup> George Veisakis,<sup>1</sup> Konstantinos Petridis,<sup>1,3</sup> Emmanuel Kymakis<sup>1</sup>

<sup>1</sup>Nanomaterials & Advanced Electronics Group, Center of Materials Technology and Photonics & Electrical Engineering Department, Technological Educational Institute (TEI) of Crete, Heraklion 71003, Crete, Greece.

<sup>2</sup>Department of Electronic Engineering Technological Educational Institute (TEI) of Crete, Chania 73132, Crete, Greece

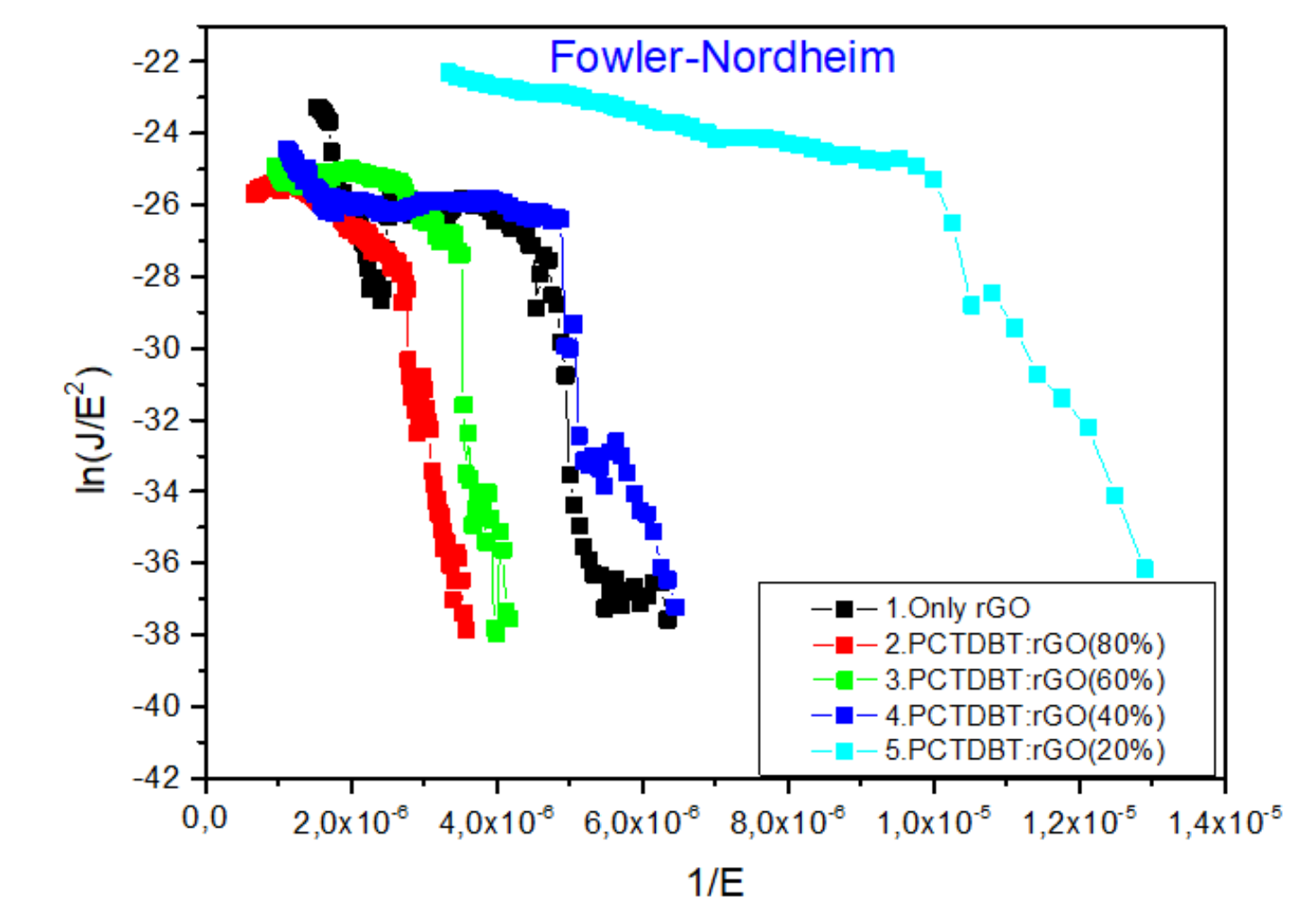
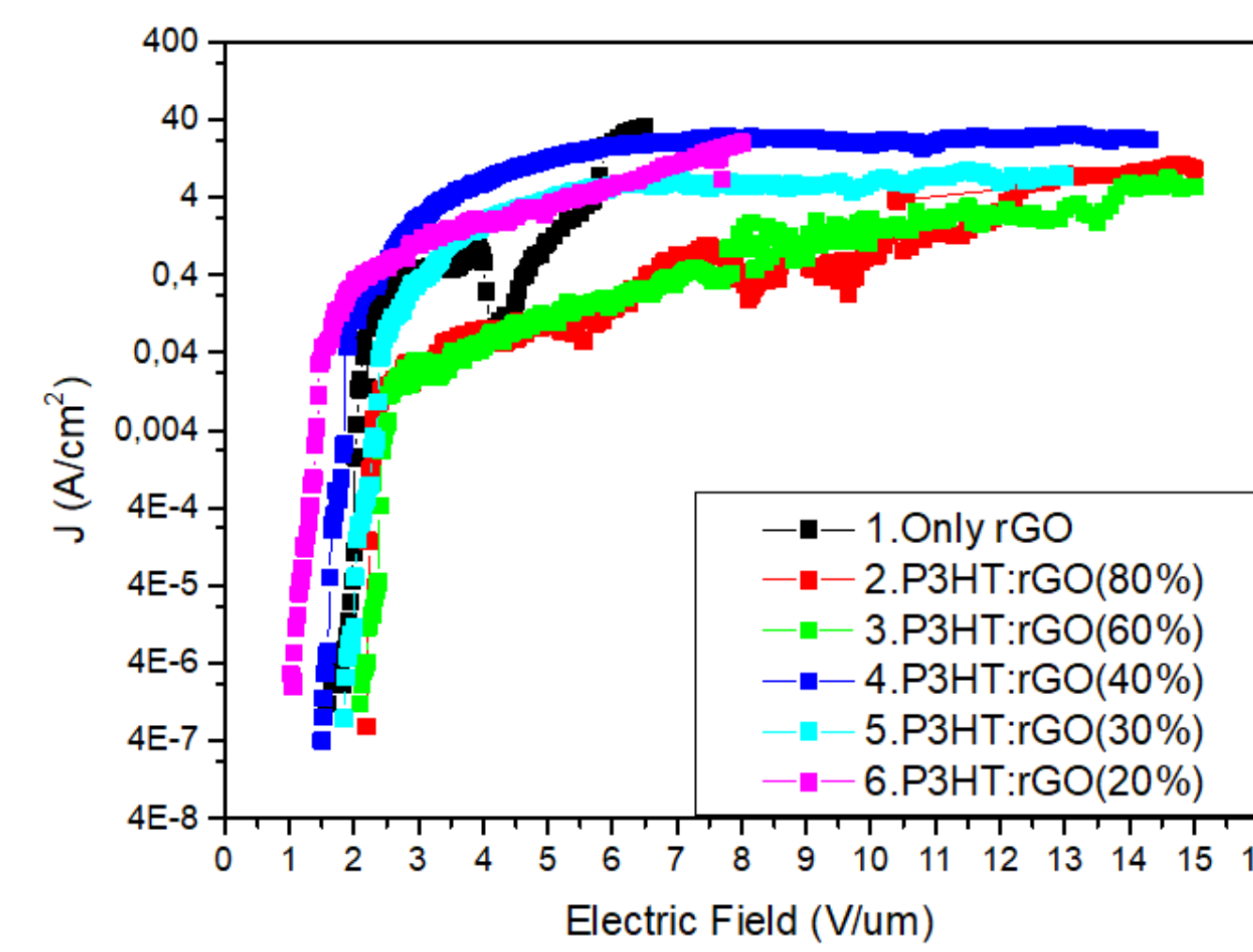
\*E-mail: [stylianakis@staff.teicrete.gr](mailto:stylianakis@staff.teicrete.gr)

Website: <http://nano.teicrete.gr>

## Abstract

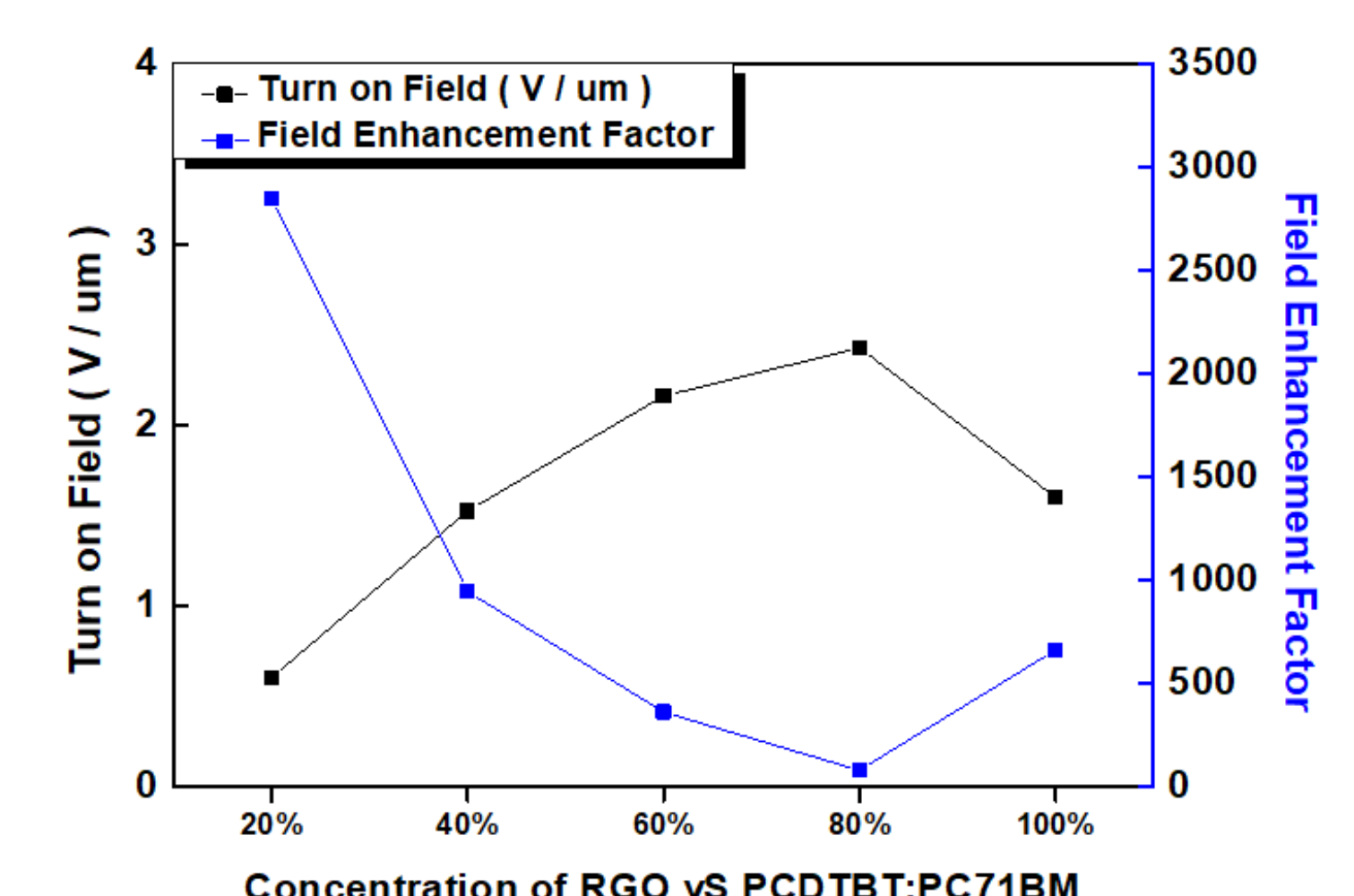
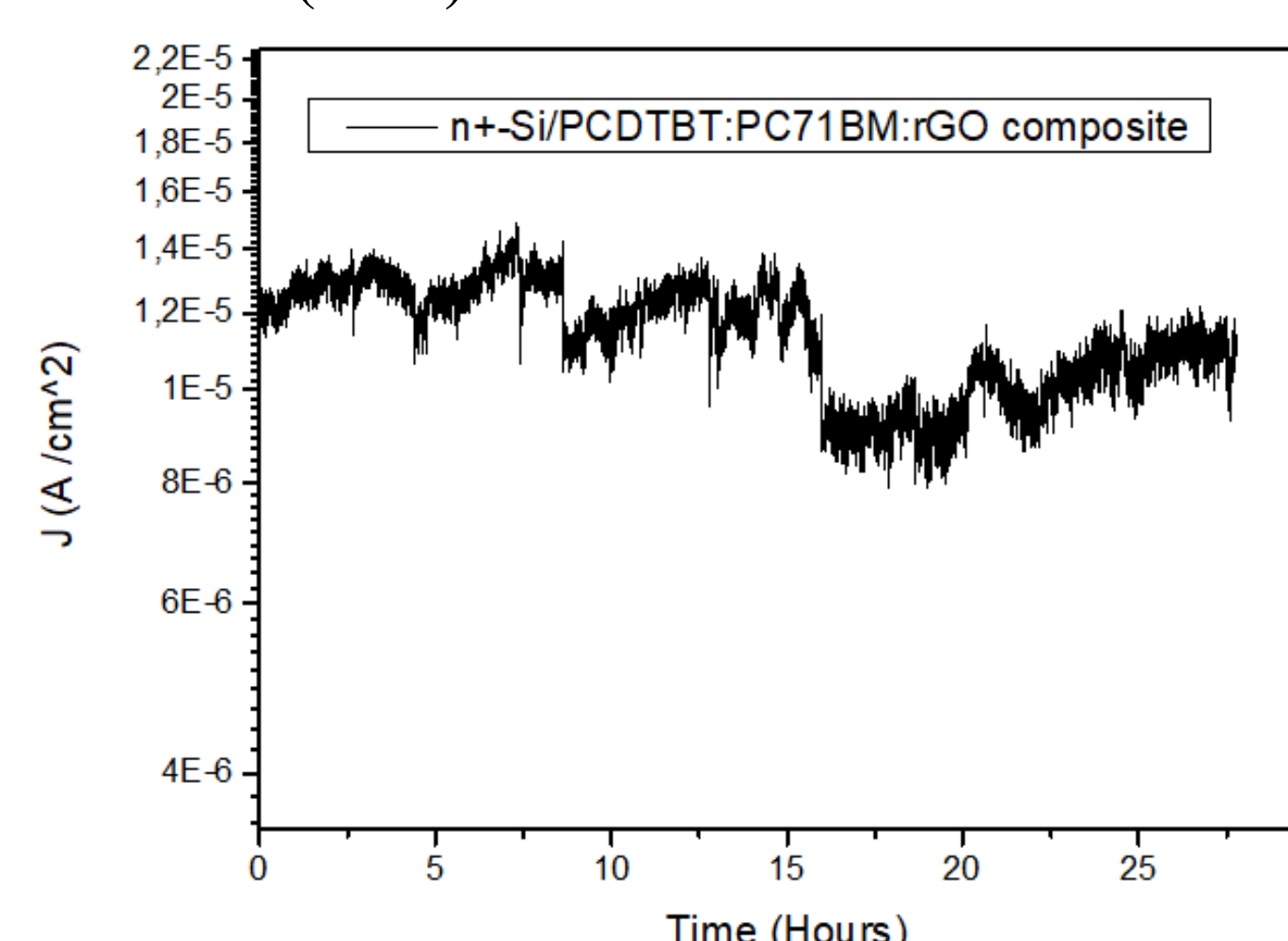
Hydroiodic acid (HI) treated - reduced graphene oxide (rGO) ink/conductive polymeric composites are considered as promising cold cathodes in terms of high geometrical aspect ratio and low field emission (FE) threshold devices [1-4]. In this study, four simple, cost-effective, solution-processed approaches for rGO-based field effect emitters were developed, optimized and compared; rGO layers were coated on a) n+ doped Si substrate, b) n+-Si/P3HT:rGO, c) n+-Si/PCDTBT:rGO and d) n+-Si/PCDTBT:PC<sub>71</sub>BM:rGO composites, respectively. The fabricated emitters were optimized by tailoring the concentration ratios of their preparation and field emission characteristics. In a critical ratio, FE performance of the composite materials was remarkably improved compared to the pristine Si, as well as n+-Si/rGO field emitter. In this context, the impact of various materials, such as polymers, fullerene derivatives, as well as different solvents on rGO function reinforcement and consequently on FE performance, upon rGO-based composites preparation, was investigated. The field emitter consisted of n+-Si/PCDTBT:PC<sub>71</sub>BM(80%):rGO(20%)/rGO displayed a field enhancement factor of ~2850, with remarkable stability over 20h and low turn-on field in 0.6V/μm. High-efficiency graphene-based FE devices realization paves the way towards low-cost, large-scale electron sources development. Finally, the contribution of this hierarchical, composite film morphology was evaluated and discussed.

## Field Emission Measurements



→ Low Electrical field threshold in P3HT:rGO(20%)

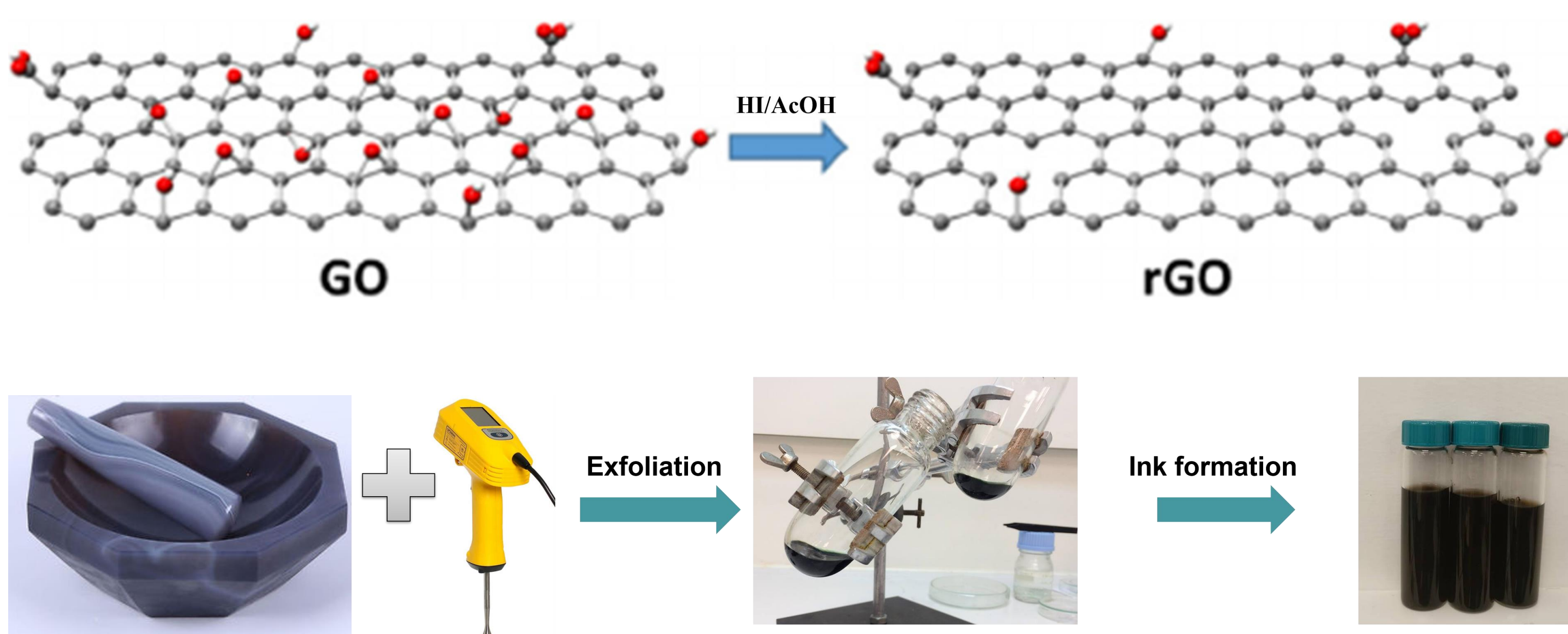
→ High Enhancement factor in PCDTBT:rGO(20%)



It can be observed that the emission current lasts for over 25 hours

→ The higher aspect ratio ( $\beta=h/d$ ) value is observed in 20% rGO, leading to amplified  $E_{10c}$

## rGO ink preparation



- GO prepared by Hummers' method
- RGO preparation by HI/AcOH reduction method
- RGO pulverization with mortar & pestle
- Inks preparation through ultrasonication probe
- High viscous rGO inks realization in THF, o-DCB and o-DCB:CB

rGO Ratio (%)	n+-Si/P3HT:rGO		n+-Si/PCDTBT:rGO		n+-Si/PCDTBT:PC <sub>71</sub> BM:rGO	
	Field Enhancement $\beta$	Turn-on Field $F_{10}$ (V/μm)	Field Enhancement $\beta$	Turn-on Field $F_{10}$ (V/μm)	Field Enhancement $\beta$	Turn-on Field $F_{10}$ (V/μm)
Only rGO	660±10	1,60±0.1	660±10	1,60±0.1	660±10	1,60±0.1
80%	300±10	2,23±0.1	170±10	2,80±0.1	80±10	2,43±0.1
60%	420±10	2,05±0.1	625±10	2,40±0.1	360±10	2,16±0.1
40%	915±10	1,53±0.1	1090±10	1,58±0.1	950±10	1,53±0.1
30%	970±10	1,40±0.1	---	---	---	---
20%	2500±10	1,03±0.1	2050±10	0,80±0.1	2850±10	0,60±0.1

## Conclusion

In this report, four rGO-based field effect emitters were developed, optimized and compared. rGO layers prepared by HI/AcOH reduction method and were coated on a) n+ doped Si substrate, b) n+-Si/P3HT:rGO, c) n+-Si/PCDTBT:rGO and d) n+-Si/PCDTBT:PC<sub>71</sub>BM:rGO composites, respectively. We investigate the FE properties of different concentrations of polymer composite solutions to control the structural and electrical properties of the substrate. It is found that the cathodes based on PCDTBT:PC<sub>71</sub>BM:rGO displayed a field enhancement factor of ~2850, with remarkable stability over 25 h and low turn-on field in 0.6V/μm.

The threshold field, enhancement factor and the remarkable Stability of FE current was remarkably improved compared to the pristine Si demonstrating that is a promising FE cathode with potential applications in vacuum microelectronics and FEDs.

## References

- [1] G. Viskadourous, et al. Applied Physics Letters 105, 203104 (2014)
- [2] G. Viskadourous, et al. ACS applied materials & interfaces 6, 388-393 (2013)
- [3] L. Sygellou, et al. RSC Advances 5, 53604-53610 (2015)
- [4] G. Viskadourous, et al. RSC Advances 6, 2768-2773 (2016)

## Acknowledgements

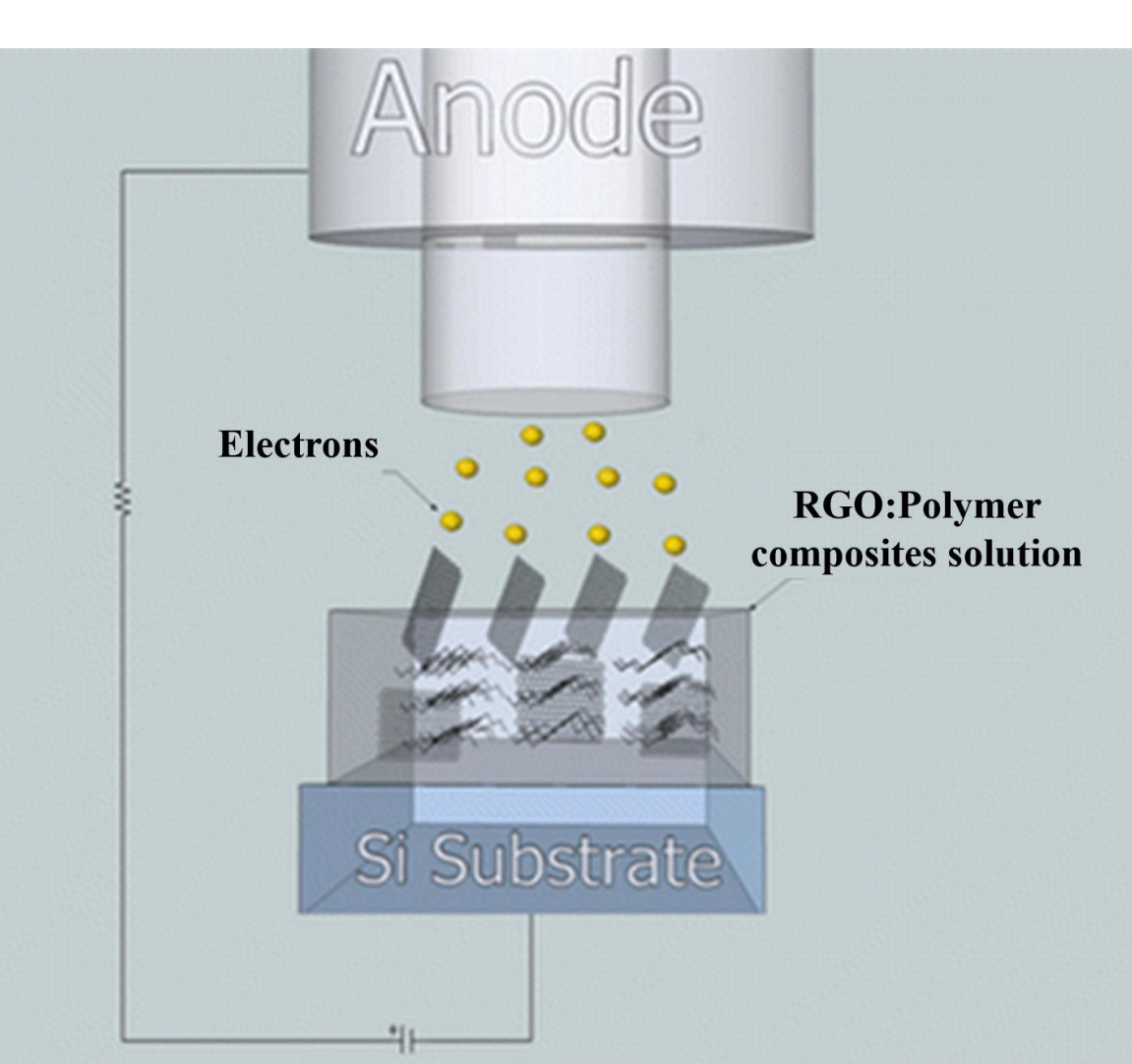
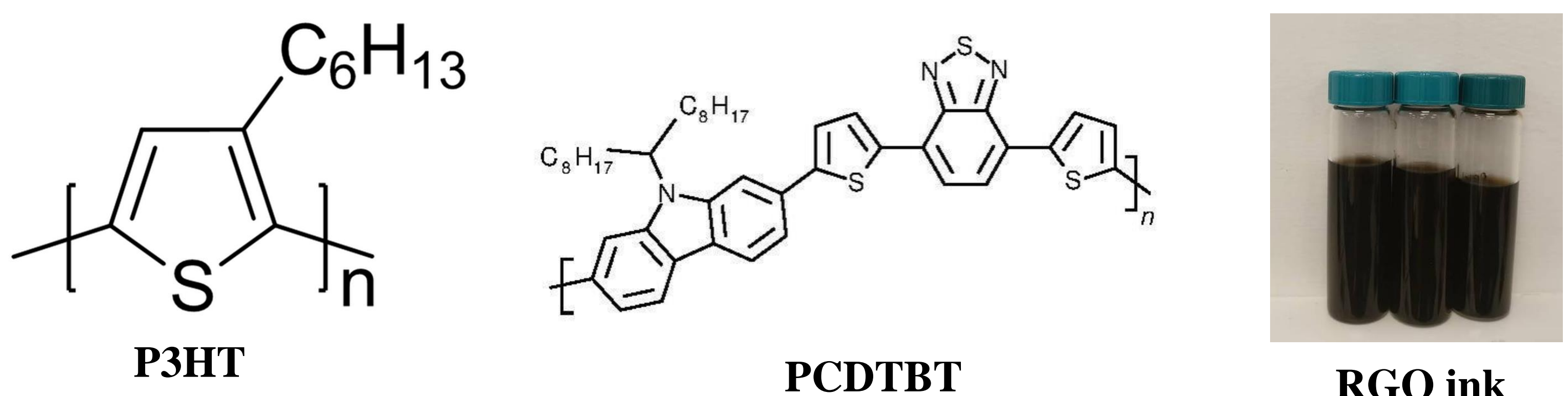
This research was funded by State Scholarships Foundation (SSF) and co-financed by the European Union (European Social Fund - ESF) and Greek national funds through the action entitled "Reinforcement of Postdoctoral Researchers", in the framework of the Operational Programme "Human Resources Development Program, Education and Lifelong Learning" of the National Strategic Reference Framework (NSRF) 2014 - 2020, Grant No. 13992



Επιχειρησιακό Πρόγραμμα Ανάπτυξη Ανθρώπινου Δυναμικού, Εκπαίδευση και Διά Βίου Μάθηση  
Με τη συγχρηματοδότηση της Ελλάδας και της Ευρωπαϊκής Ένωσης



## rGO:Polymers Composites preparation



- THF and o-DCB to prepare P3HT and PCDTBT solutions
- RGO inks addition to the P3HT and PCDTBT solutions in controlled volume ratios equal to 20:80, 40:60, 60:40, 80:20 and 100%
- RGO:Polymer composites realization
- PCDTBT:PC<sub>71</sub>BM:rGO composites fabrication

